

<b>Notice of References Cited</b>	Application/Control No. 10/533,084	Applicant(s)/Patent Under Reexamination VAUTHIER ET AL.	
	Examiner Kevin K. Hill, Ph.D.	Art Unit 1633	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,096,331 A	08-2000	Desai et al.	424/422
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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